Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/829,334	CHANG, CHIH YUAN
Examiner	Art Unit

3764

Steve R. Crow

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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